

**Search Notes**

Application/Control No.

10/656,409

Examiner

Randall Chin

Applicant(s)/Patent under  
Reexamination

D'AGUANNO, FRANCIS D.

Art Unit

1744

**SEARCHED**

Class	Subclass	Date	Examiner
15	185		
15	236.01		
15	236.05		
15	236.06		
15	236.07		
15	236.08		
15	236.09		
30	153		
30	255		
7	128		
81	177.6		
81	177.7		
81	427.5	9/18/2006	RC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		
Inventor name search		
Hwei-Siu Payer, Cl..30 search		
Debra Meislin, Cl. 7 and 81 search	9/18/2006	RC